

## CoolMOS™ Power Transistor

### Features

- Lowest figure-of-merit  $R_{ON} \times Q_g$
- Extreme dv/dt rated
- High peak current capability
- Qualified according to JEDEC<sup>1)</sup> for industrial applications
- Pb-free lead plating; RoHS compliant
- Ultra low gate charge

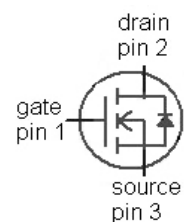
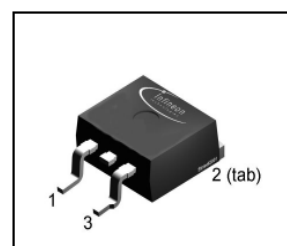
### CoolMOS™ 900V is designed for:

- Quasi Resonant Flyback / Forward topologies
- SMPS
- PC Silverbox
- Lighting
- Solar

### Product Summary

|                                         |      |          |
|-----------------------------------------|------|----------|
| $V_{DS} @ T_J=25^\circ\text{C}$         | 900  | V        |
| $R_{DS(on),max} @ T_J=25^\circ\text{C}$ | 0.34 | $\Omega$ |
| $Q_{g,typ}$                             | 94   | nC       |

PG-TO263



| Type        | Package  | Marking |
|-------------|----------|---------|
| IPB90R340C3 | PG-TO263 | 9R340C  |

### Maximum ratings, at $T_J=25^\circ\text{C}$ , unless otherwise specified

| Parameter                                               | Symbol         | Conditions                             | Value       | Unit             |
|---------------------------------------------------------|----------------|----------------------------------------|-------------|------------------|
| Continuous drain current                                | $I_D$          | $T_C=25^\circ\text{C}$                 | 15          | A                |
|                                                         |                | $T_C=100^\circ\text{C}$                | 9.5         |                  |
| Pulsed drain current <sup>2)</sup>                      | $I_{D,pulse}$  | $T_C=25^\circ\text{C}$                 | 34          |                  |
| Avalanche energy, single pulse                          | $E_{AS}$       | $I_D=3.1\text{ A}, V_{DD}=50\text{ V}$ | 678         | mJ               |
| Avalanche energy, repetitive $t_{AR}$ <sup>2),3)</sup>  | $E_{AR}$       | $I_D=3.1\text{ A}, V_{DD}=50\text{ V}$ | 1           |                  |
| Avalanche current, repetitive $t_{AR}$ <sup>2),3)</sup> | $I_{AR}$       |                                        | 3.1         | A                |
| MOSFET dv/dt ruggedness                                 | dv/dt          | $V_{DS}=0\dots400\text{ V}$            | 50          | V/ns             |
| Gate source voltage                                     | $V_{GS}$       | static                                 | $\pm 20$    | V                |
|                                                         |                | AC ( $f>1\text{ Hz}$ )                 | $\pm 30$    |                  |
| Power dissipation                                       | $P_{tot}$      | $T_C=25^\circ\text{C}$                 | 208         | W                |
| Operating and storage temperature                       | $T_J, T_{stg}$ |                                        | -55 ... 150 | $^\circ\text{C}$ |

**Maximum ratings**, at  $T_J=25\text{ °C}$ , unless otherwise specified

| Parameter                           | Symbol        | Conditions         | Value | Unit |
|-------------------------------------|---------------|--------------------|-------|------|
| Continuous diode forward current    | $I_S$         | $T_C=25\text{ °C}$ | 9.2   | A    |
| Diode pulse current <sup>2)</sup>   | $I_{S,pulse}$ |                    | 34    |      |
| Reverse diode $dv/dt$ <sup>4)</sup> | $dv/dt$       |                    | 4     | V/ns |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

#### Thermal characteristics

|                                                                                                                                                  |            |                                                                             |   |    |     |     |
|--------------------------------------------------------------------------------------------------------------------------------------------------|------------|-----------------------------------------------------------------------------|---|----|-----|-----|
| Thermal resistance, junction - case                                                                                                              | $R_{thJC}$ |                                                                             | - | -  | 0.6 | K/W |
| Thermal resistance, junction - ambient                                                                                                           | $R_{thJA}$ | SMD version, device on PCB: at minimum footprint                            | - | -  | 62  |     |
|                                                                                                                                                  | $R_{thJA}$ | SMD version, device on PCB: at 6 cm <sup>2</sup> cooling area <sup>5)</sup> | - | 35 | -   |     |
| Soldering temperature, only reflow soldering allowed; part not qualified for direct wave soldering but bottom side PCB wave soldering is allowed | $T_{sold}$ | reflow MSL1                                                                 | - | -  | 260 | °C  |

**Electrical characteristics**, at  $T_J=25\text{ °C}$ , unless otherwise specified

#### Static characteristics

|                                  |               |                                                                   |     |      |      |               |
|----------------------------------|---------------|-------------------------------------------------------------------|-----|------|------|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$                | 900 | -    | -    | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ , $I_D=1\text{ mA}$                               | 2.5 | 3    | 3.5  |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=900\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=25\text{ °C}$  | -   | -    | 2    | $\mu\text{A}$ |
|                                  |               | $V_{DS}=900\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=150\text{ °C}$ | -   | 20   | -    |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                        | -   | -    | 100  | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=9.2\text{ A}$ , $T_J=25\text{ °C}$    | -   | 0.28 | 0.34 | $\Omega$      |
|                                  |               | $V_{GS}=10\text{ V}$ , $I_D=9.2\text{ A}$ , $T_J=150\text{ °C}$   | -   | 0.76 | -    |               |
| Gate resistance                  | $R_G$         | $f=1\text{ MHz}$ , open drain                                     | -   | 1.3  | -    | $\Omega$      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                                                            |              |                                                                                         |   |      |   |    |
|------------------------------------------------------------|--------------|-----------------------------------------------------------------------------------------|---|------|---|----|
| Input capacitance                                          | $C_{iss}$    | $V_{GS}=0\text{ V}, V_{DS}=100\text{ V},$<br>$f=1\text{ MHz}$                           | - | 2400 | - | pF |
| Output capacitance                                         | $C_{oss}$    |                                                                                         | - | 120  | - |    |
| Effective output capacitance, energy related <sup>6)</sup> | $C_{o(er)}$  | $V_{GS}=0\text{ V}, V_{DS}=0\text{ V}$<br>to 500 V                                      | - | 71   | - |    |
| Effective output capacitance, time related <sup>7)</sup>   | $C_{o(tr)}$  |                                                                                         | - | 280  | - |    |
| Turn-on delay time                                         | $t_{d(on)}$  | $V_{DD}=400\text{ V},$<br>$V_{GS}=10\text{ V}, I_D=9.2\text{ A},$<br>$R_G=23.1\ \Omega$ | - | 70   | - | ns |
| Rise time                                                  | $t_r$        |                                                                                         | - | 20   | - |    |
| Turn-off delay time                                        | $t_{d(off)}$ |                                                                                         | - | 400  | - |    |
| Fall time                                                  | $t_f$        |                                                                                         | - | 25   | - |    |

**Gate Charge Characteristics**

|                       |               |                                                                              |   |     |   |    |
|-----------------------|---------------|------------------------------------------------------------------------------|---|-----|---|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=400\text{ V}, I_D=9.2\text{ A},$<br>$V_{GS}=0\text{ to }10\text{ V}$ | - | 11  | - | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                              | - | 41  | - |    |
| Gate charge total     | $Q_g$         |                                                                              | - | 94  | - |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                              | - | 4.6 | - | V  |

**Reverse Diode**

|                               |           |                                                                    |   |     |     |               |
|-------------------------------|-----------|--------------------------------------------------------------------|---|-----|-----|---------------|
| Diode forward voltage         | $V_{SD}$  | $V_{GS}=0\text{ V}, I_F=9.2\text{ A},$<br>$T_J=25\text{ °C}$       | - | 0.8 | 1.2 | V             |
| Reverse recovery time         | $t_{rr}$  | $V_R=400\text{ V}, I_F=I_S,$<br>$di_F/dt=100\text{ A}/\mu\text{s}$ | - | 510 | -   | ns            |
| Reverse recovery charge       | $Q_{rr}$  |                                                                    | - | 11  | -   | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rrm}$ |                                                                    | - | 41  | -   | A             |

<sup>1)</sup> J-STD20 and JESD22

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{J,max}$

<sup>3)</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV}=E_{AR} \cdot f$ .

<sup>4)</sup>  $I_{SD} \leq I_D$ ,  $di/dt \leq 200\text{ A}/\mu\text{s}$ ,  $V_{DCLink}=400\text{ V}$ ,  $V_{peak} < V_{(BR)DSS}$ ,  $T_J < T_{J,max}$ , identical low side and high side switch

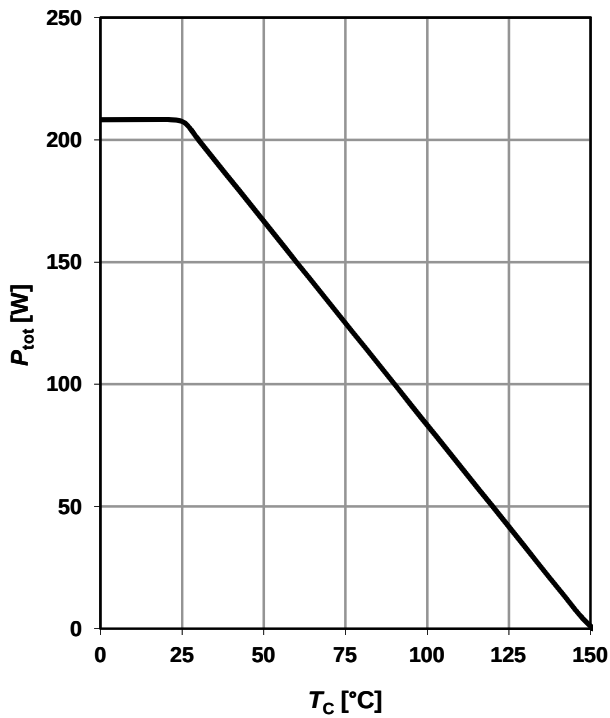
<sup>5)</sup> Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

<sup>6)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 50%  $V_{DSS}$ .

<sup>7)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 50%  $V_{DSS}$ .

## 1 Power dissipation

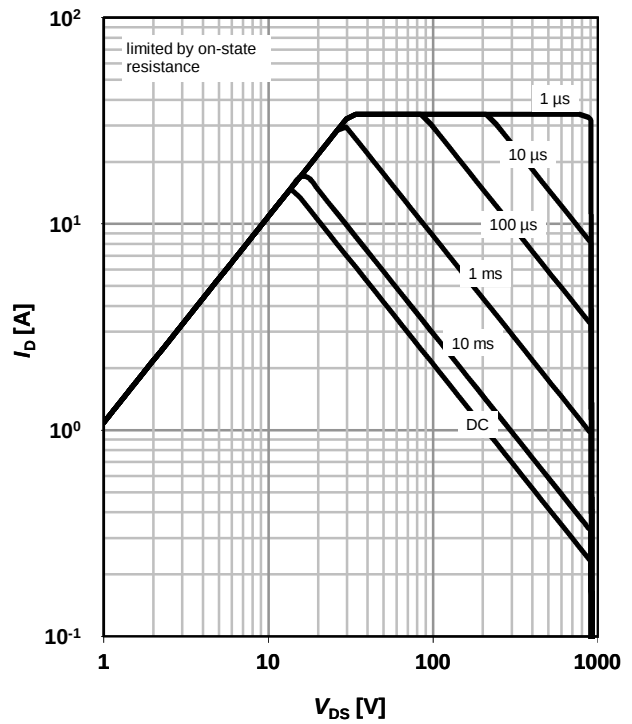
$$P_{\text{tot}} = f(T_c)$$



## 2 Safe operating area

$$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D = 0$$

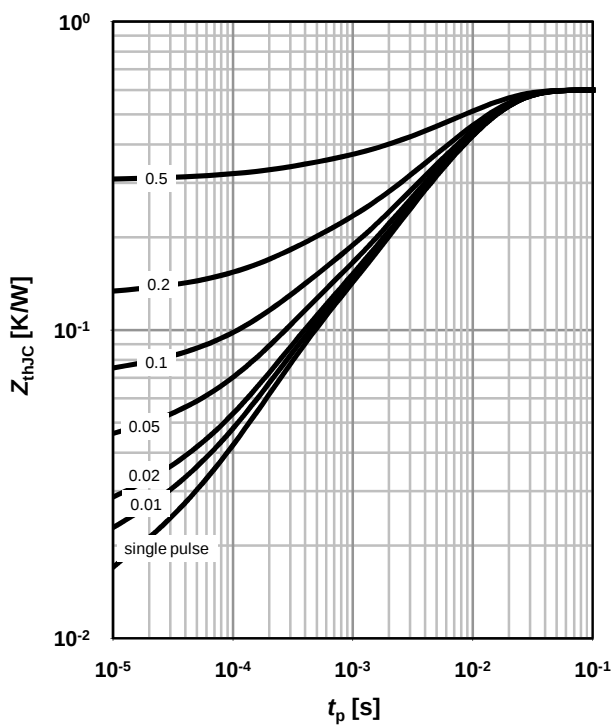
parameter:  $t_p$



## 3 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

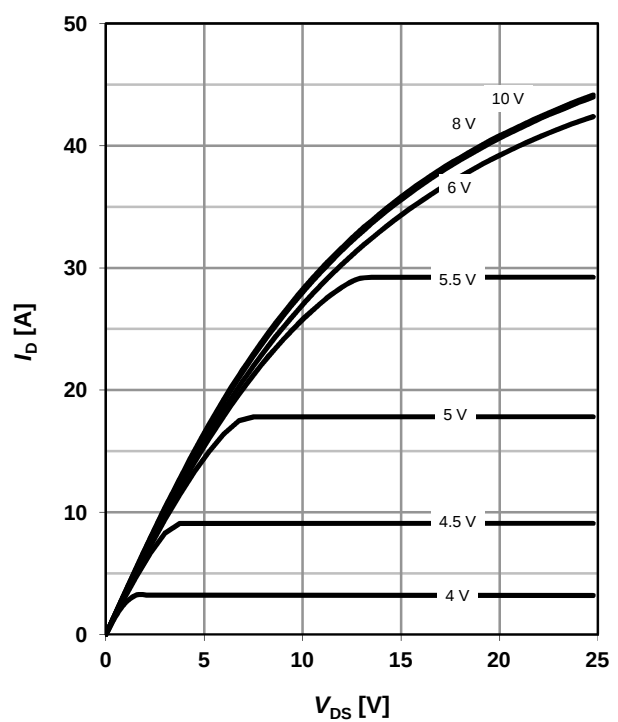
parameter:  $D = t_p / T$



## 4 Typ. output characteristics

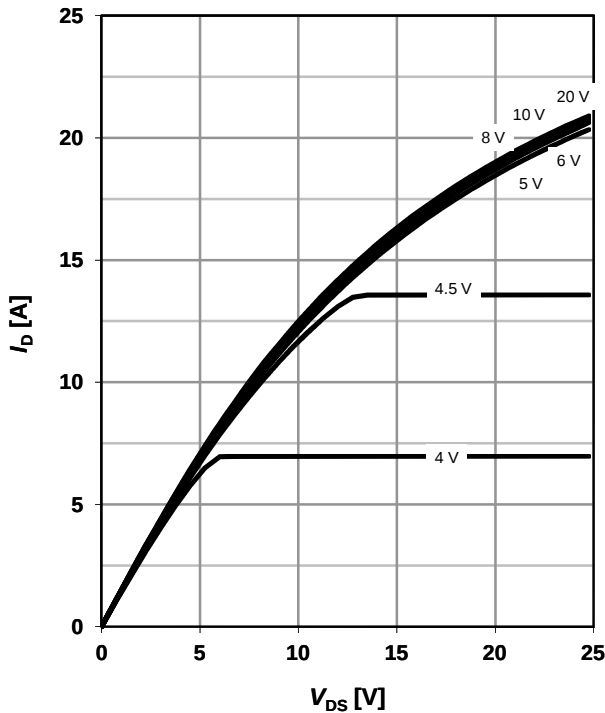
$$I_D = f(V_{DS}); T_J = 25^\circ\text{C}$$

parameter:  $V_{GS}$



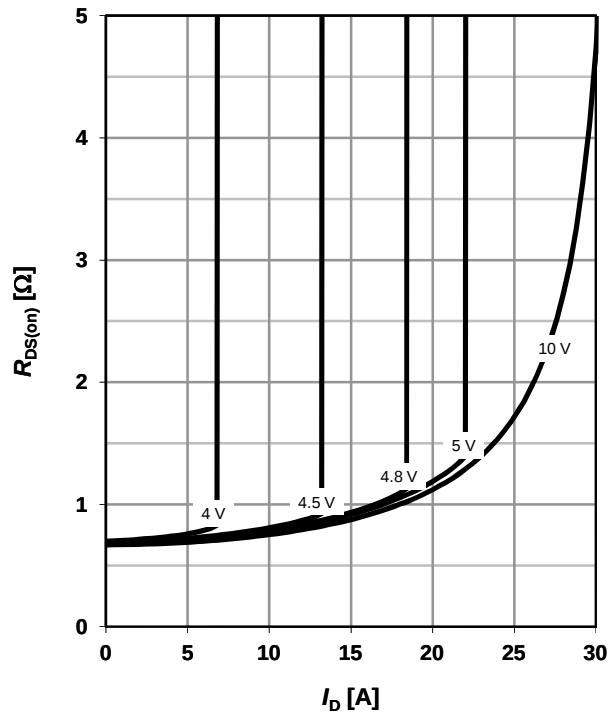
### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_J = 150^\circ\text{C}$ 

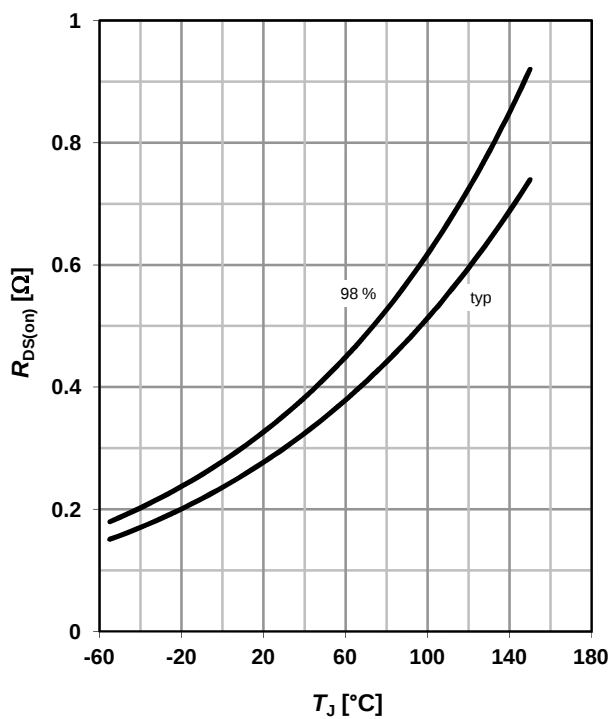
parameter:  $V_{GS}$ 


### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_J = 150^\circ\text{C}$ 

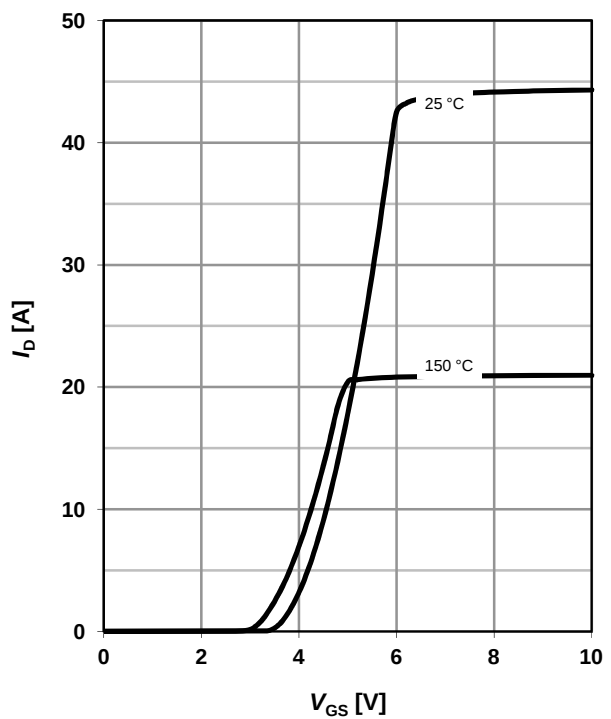
parameter:  $V_{GS}$ 


### 7 Drain-source on-state resistance

 $R_{DS(on)} = f(T_J); I_D = 9.2\text{ A}; V_{GS} = 10\text{ V}$ 


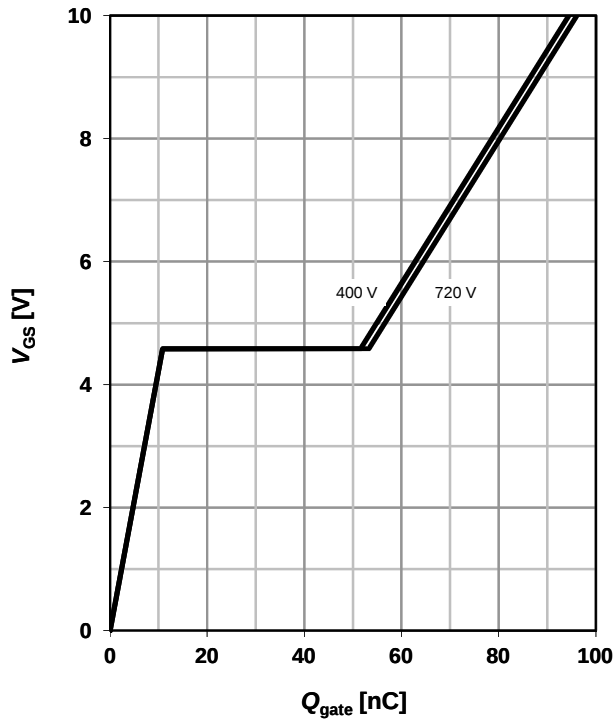
### 8 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 20\text{ V}$ 

parameter:  $T_J$ 


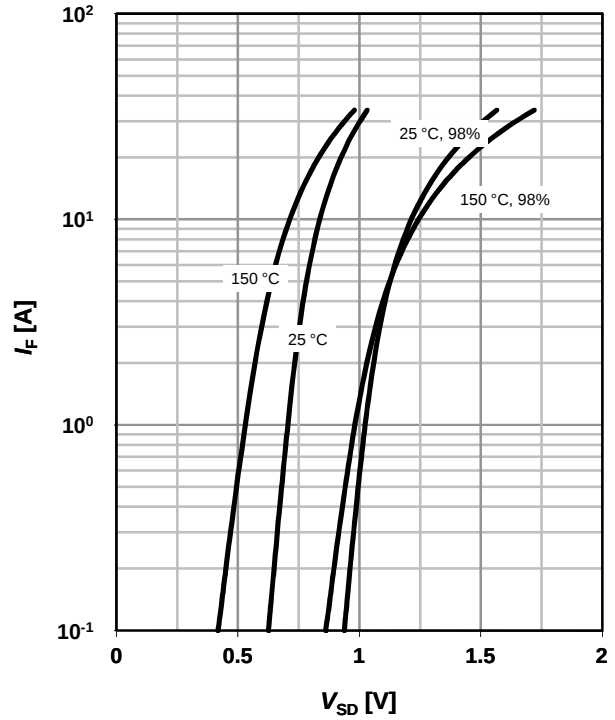
### 9 Typ. gate charge

 $V_{GS}=f(Q_{gate}); I_D=9.2\text{ A pulsed}$ 

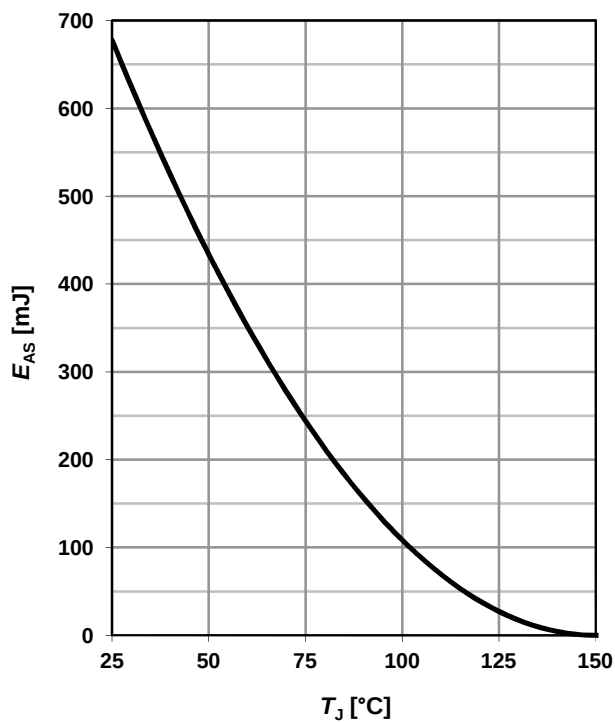
parameter:  $V_{DD}$ 


### 10 Forward characteristics of reverse diode

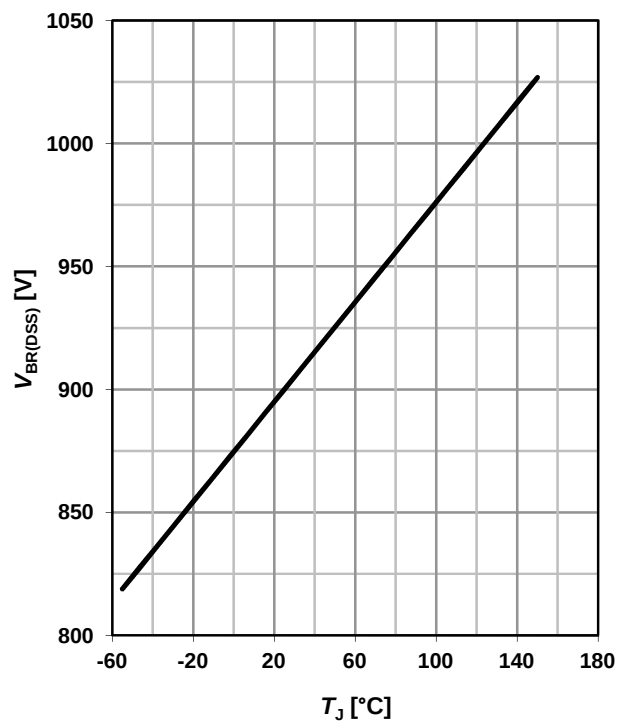
 $I_F=f(V_{SD})$ 

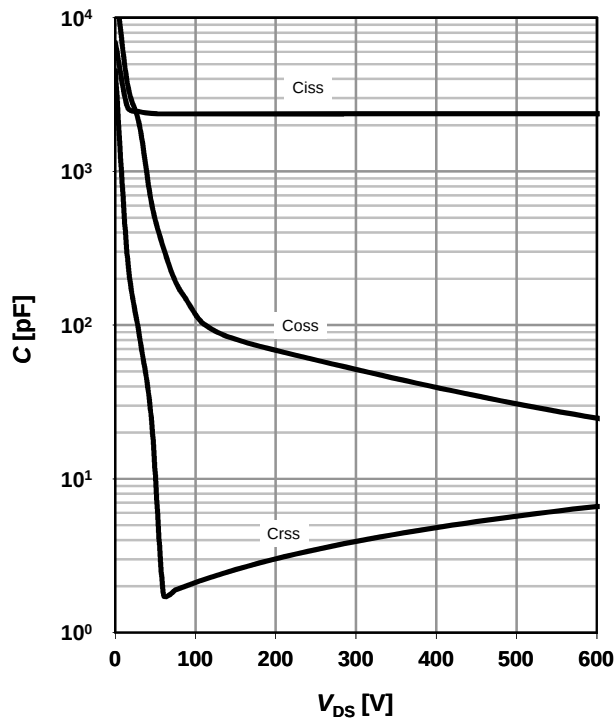
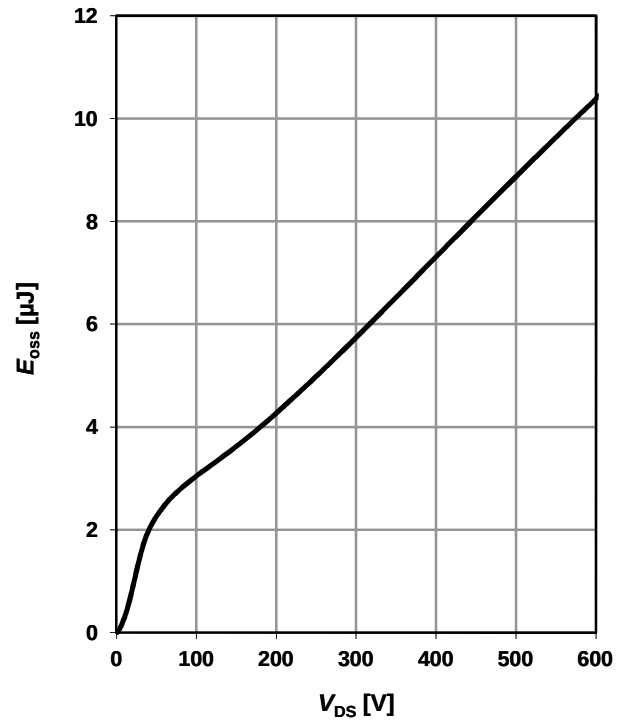
parameter:  $T_J$ 


### 11 Avalanche energy

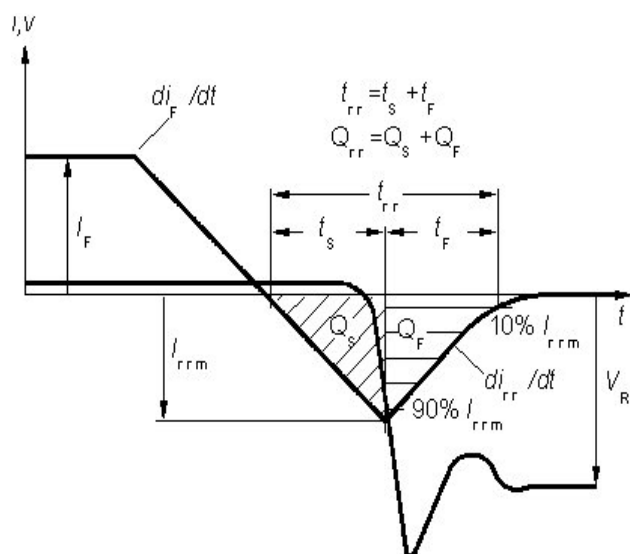
 $E_{AS}=f(T_J); I_D=3.1\text{ A}; V_{DD}=50\text{ V}$ 


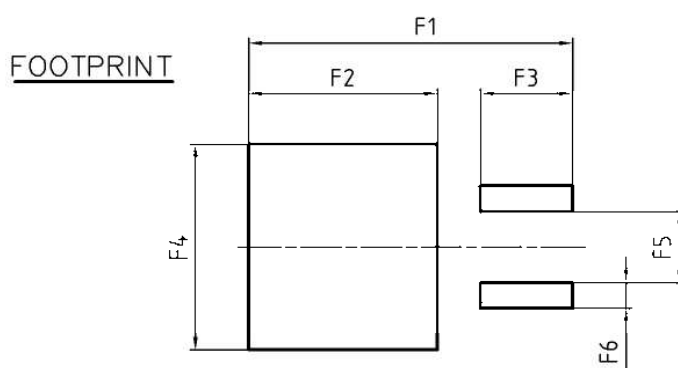
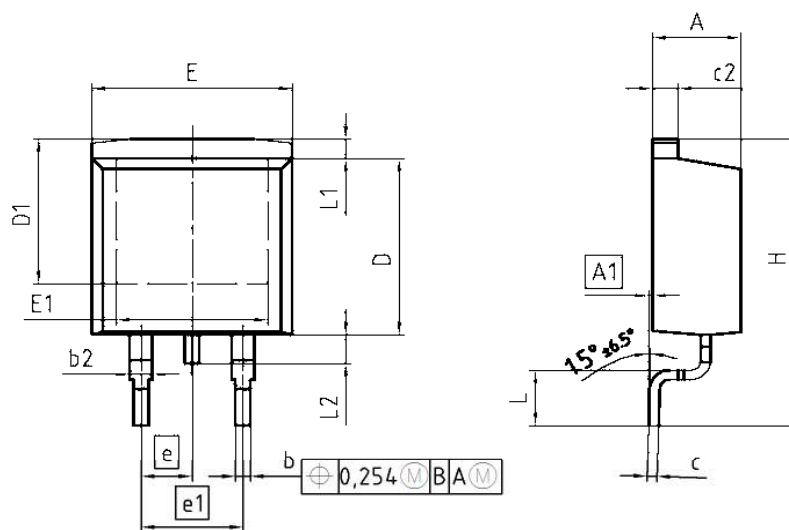
### 12 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_J); I_D=0.25\text{ mA}$ 


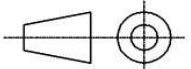
**13 Typ. capacitances**
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 

**14 Typ.  $C_{oss}$  stored energy**
 $E_{oss} = f(V_{DS})$ 


# Definition of diode switching characteristics





| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.30        | 4.57  | 0.169  | 0.180 |
| A1  | 0.00        | 0.25  | 0.000  | 0.010 |
| b   | 0.65        | 0.85  | 0.026  | 0.033 |
| b2  | 0.95        | 1.15  | 0.037  | 0.045 |
| c   | 0.33        | 0.65  | 0.013  | 0.026 |
| c2  | 1.17        | 1.40  | 0.046  | 0.055 |
| D   | 8.51        | 9.45  | 0.335  | 0.372 |
| D1  | 7.10        | 7.90  | 0.280  | 0.311 |
| E   | 9.80        | 10.31 | 0.386  | 0.406 |
| E1  | 6.50        | 8.60  | 0.256  | 0.339 |
| e   | 2.54        |       | 0.100  |       |
| e1  | 5.08        |       | 0.200  |       |
| N   | 2           |       | 2      |       |
| H   | 14.61       | 15.88 | 0.575  | 0.625 |
| L   | 2.29        | 3.00  | 0.090  | 0.118 |
| L1  | 0.70        | 1.60  | 0.028  | 0.063 |
| L2  | 1.00        | 1.78  | 0.039  | 0.070 |
| F1  | 16.05       | 16.25 | 0.632  | 0.640 |
| F2  | 9.30        | 9.50  | 0.366  | 0.374 |
| F3  | 4.50        | 4.70  | 0.177  | 0.185 |
| F4  | 10.70       | 10.90 | 0.421  | 0.429 |
| F5  | 3.65        | 3.85  | 0.144  | 0.152 |
| F6  | 1.25        | 1.45  | 0.049  | 0.057 |

|                                                                                                              |
|--------------------------------------------------------------------------------------------------------------|
| DOCUMENT NO.<br>Z8B00003324                                                                                  |
| SCALE<br>0 5 5 7.5mm                                                                                         |
| EUROPEAN PROJECTION<br> |
| ISSUE DATE<br>30-08-2007                                                                                     |
| REVISION<br>01                                                                                               |

**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**  
**© 2008 Infineon Technologies AG**  
**All Rights Reserved.**

**Legal Disclaimer**

The information given in this document shall in no event be regarded as a guarantee of

conditions or characteristics. With respect to any examples or hints given herein, any typical

values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

**Information**

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

**Warnings**

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



**Стандарт  
Электрон  
Связь**

Мы молодая и активно развивающаяся компания в области поставок электронных компонентов. Мы поставляем электронные компоненты отечественного и импортного производства напрямую от производителей и с крупнейших складов мира.

Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

Осуществляем поставки продукции под контролем ВП МО РФ на предприятия военно-промышленного комплекса России , а также работаем в рамках 275 ФЗ с открытием отдельных счетов в уполномоченном банке. Система менеджмента качества компании соответствует требованиям ГОСТ ISO 9001.

Минимальные сроки поставки, гибкие цены, неограниченный ассортимент и индивидуальный подход к клиентам являются основой для выстраивания долгосрочного и эффективного сотрудничества с предприятиями радиоэлектронной промышленности, предприятиями ВПК и научно-исследовательскими институтами России.

С нами вы становитесь еще успешнее!

**Наши контакты:**

**Телефон:** +7 812 627 14 35

**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

**Адрес:** 198099, Санкт-Петербург,  
Промышленная ул, дом № 19, литера Н,  
помещение 100-Н Офис 331